

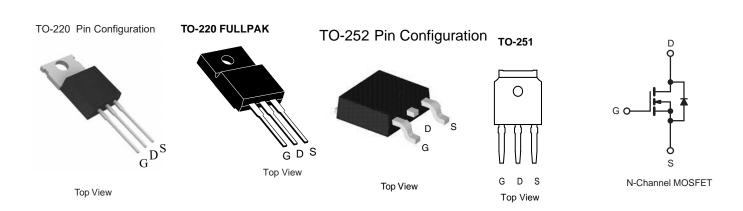
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Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	600			
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	4.4		
Q _g (Max.) (nC)	18			
Q _{gs} (nC)	3.0			
Q _{gd} (nC)	8.9			
Configuration	Single			

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Surface Mount
- Straight Lead
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC



PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V _{DS}	600	V		
Gate-Source Voltage	V _{GS}	± 20	V		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$ $T_C = 100 \degree C$		2.0	А	
	$V_{GS} a 10 V$ $T_{C} = 100 °$	C	1.3		
Pulsed Drain Current ^a	I _{DM}	8.0			
Linear Derating Factor		0.33	W/°C		
Linear Derating Factor (PCB Mount) ^e		0.020	WV/ C		
Single Pulse Avalanche Energy ^b	E _{AS}	74	mJ		
Repetitive Avalanche Current ^a	I _{AR}	2.0	A		
Repetitive Avalanche Energy ^a	E _{AR}	4.2	mJ		
Maximum Power Dissipation	T _C = 25 °C	Р	42	w	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C		2.5	vv	
Peak Diode Recovery dV/dtc	dV/dt	3.0	V/ns		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		260 ^d	1	

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 37 mH, $R_g = 25 \Omega$, $I_{AS} = 2.0 \text{ A}$ (see fig. 12). c. $I_{SD} \le 2.0 \text{ A}$, $dI/dt \le 40 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$. d. 1.6 mm from case. e. When mounted on 1" scurge DCP (FD 4 or C 10 methods)

e. When mounted on 1" square PCB (FR-4 or G-10 material).

* Pb containing terminations are not RoHS compliant, exemptions may apply



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	-	110	
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	3.0	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$		600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C, I _D = 1 mA	-	0.88	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 V$		-	± 100	nA
	I _{DSS}	$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	100	
Zero Gate Voltage Drain Current		V _{DS} = 480 V	V _{DS} = 480 V, V _{GS} = 0 V, T _J = 125 °C		-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 1.2 A ^b	-	-	4.4	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 1.2 A	1.4	-	-	S
Dynamic					•	•	
Input Capacitance	C _{iss}	$V_{GS} = 0 V, \\ V_{DS} = -25 V, \\ f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	350	-	pF
Output Capacitance	Coss			-	48	-	
Reverse Transfer Capacitance	C _{rss}			-	8.6	-	
Total Gate Charge	Qg		$V_{GS} = 10 \text{ V} \qquad I_{D} = 2.0 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	-	-	18	nC
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$		-	-	3.0	
Gate-Drain Charge	Q _{gd}			-	-	8.9	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	- V =	V _{DD} = 300 V, I _D = 2.0 A,		23	-	- ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 18 \Omega$, $R_D = 135 \Omega$, see fig. 10 ^b		-	30	-	
Fall Time	t _f			-	25	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH
Internal Source Inductance	Ls			-	7.5	-	
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.0	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.0	
Body Diode Voltage	V_{SD}	T _J = 25 °C	$I_{\rm S}$ = 2.0 A, $V_{\rm GS}$ = 0 V ^b	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 2.0 A, dl/dt = 100 A/μs ^b		-	290	580	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.67	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D					L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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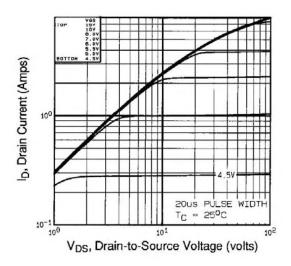


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

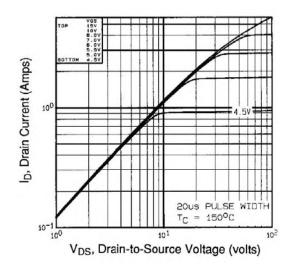


Fig. 2 - Typical Output Characteristics, $T_C = 150 \ ^{\circ}C$

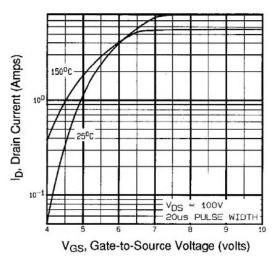


Fig. 3 - Typical Transfer Characteristics

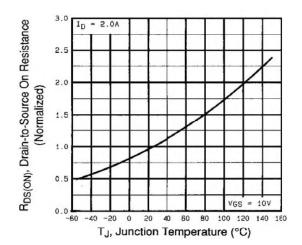


Fig. 4 - Normalized On-Resistance vs. Temperature



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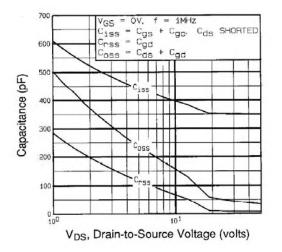
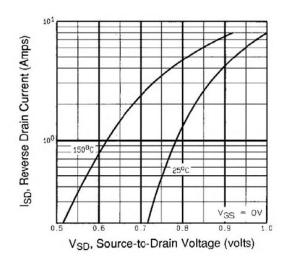


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





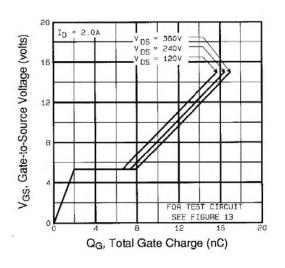


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

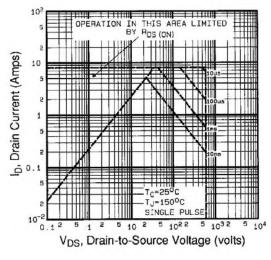


Fig. 8 - Maximum Safe Operating Area



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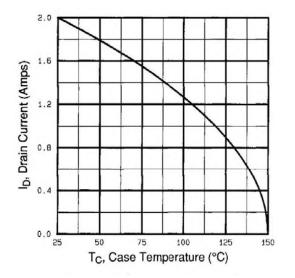


Fig. 9 - Maximum Drain Current vs. Case Temperature

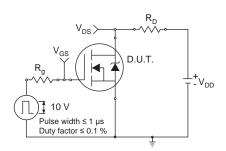


Fig. 10a - Switching Time Test Circuit

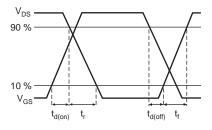


Fig. 10b - Switching Time Waveforms

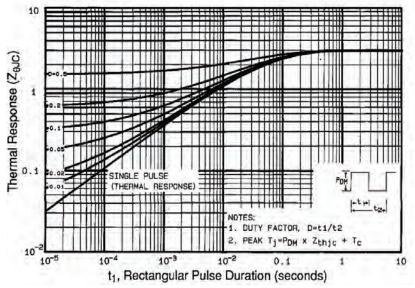


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



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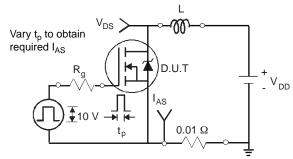


Fig. 12a - Unclamped Inductive Test Circuit

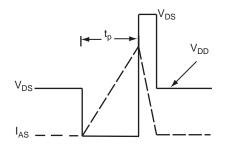


Fig. 12b - Unclamped Inductive Waveforms

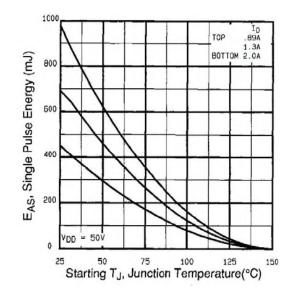


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

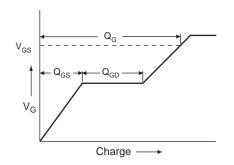


Fig. 13a - Basic Gate Charge Waveform

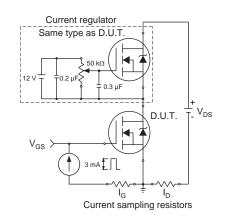
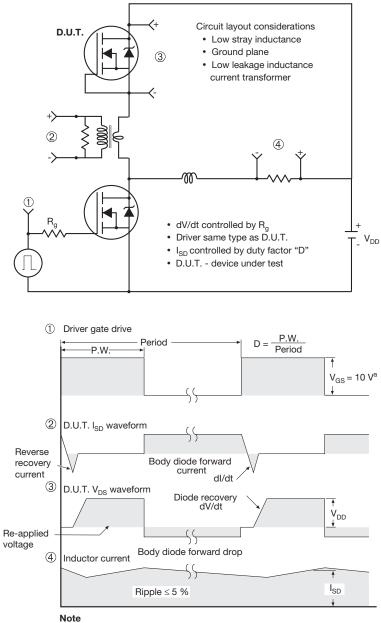


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 \text{ V}$ for logic level devices

Fig. 14 - For N-Channel



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